

<b>Notice of References Cited</b>	Application/Control No. 10/537,710	Applicant(s)/Patent Under Reexamination ISHIMATSU, HIDEAKI	
	Examiner Jeong S. Park	Art Unit 2154	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0178261	11-2002	Chang et al.	709/225
*	B	US-2002/0143888	10-2002	Lisiecki et al.	709/214
	C	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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